

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/749,980	LEE, ELAINE	
	Examiner	Art Unit	
	Annette R. Reimers	3733	Page 1 of 1

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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